

Effect of heat treatment on electrochromic properties of TiO₂ thin films

Shih-Yuan Lin · Ying-Chung Chen · Chih-Ming Wang · Chan-Chih Liu

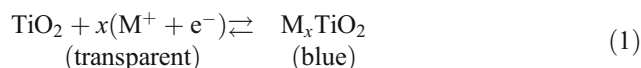
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Abstract Electrochromic titanium oxide (TiO₂) films were deposited on ITO/glass substrates by chemical solution deposition (CSD). The stock solutions were spin-coated onto substrates and then heated at various temperatures (200–500 °C) in various oxygen concentrations (0–80%) for 10 min. The effects of the processing parameters on the electrochromic properties of TiO₂ films were investigated. X-ray diffraction measurements demonstrated that the amorphous TiO₂ films were crystallized to form anatase films above 400 °C. The electrochromic properties and transmittance of TiO₂ films were measured in 1 M LiClO₄–propylene carbonate (PC) non-aqueous electrolyte. An amorphous 350 nm-thick TiO₂ film that was heated at 300°C in 60% ambient oxygen exhibited the maximum transmittance variation ($\Delta T\%$), 14.2%, between the bleached state and the colored state, with a ΔOD of 0.087, Q of 10.9 mC/cm², η of 7.98 cm²/C and x in Li_{*x*}ClO₄ of 0.076 at a wavelength (λ) of 550 nm.

Keywords Electrochromic · Titanium oxide · Heat treatment · Cyclic voltammograms · Transmittance

Introduction

Recently, TiO₂ films have been studied as counter electrodes (CE) because their microstructural features favor ion transportation. Li-doped TiO₂ electrodes have been demonstrated to be useful in photoelectrochemical solar cells and Li ion batteries [1, 2]. During the cyclic voltammetry (CV) of propylene carbonate (PC), applying a cathodic potential changed the transmittance of TiO₂ films from a transparent state to blue, indicating electrochromic properties. The electrochromic properties of almost all transition metal oxides have been studied because of their potential applications in electrochromic devices (ECDs) such as displays, smart windows, sunroofs, and rearview and car mirrors, since they can, applying a voltage pulse, reversibly change their color [3–7]. These oxides can be colored anodically (NiO_{*x*}, IrO₂, Rh₂O₃) or cathodically (WO₃, MoO₃, TiO₂). TiO₂ is a member of the cathodic coloration class. The widely accepted model of the electrochromic reaction is the double injection of electrons and monovalent ions into the oxide matrix, as follows: [8]



where M⁺ can be H⁺ or Li⁺. The insertion coefficient, x , can saturate at a value of one depending on the microstructure of the deposited thin film.

Since the electrochromic properties are strongly related to the microstructure and the surface morphology of the films, the synthesis of crystalline TiO₂ films has attracted interest in recent years. However, the amorphous TiO₂ film has a greater charge capacity and higher coloration efficiency than an anatase TiO₂ film because it has a more open microstructure [9, 10]. The goal of this study is to prepare amorphous and anatase TiO₂ films by chemical solution

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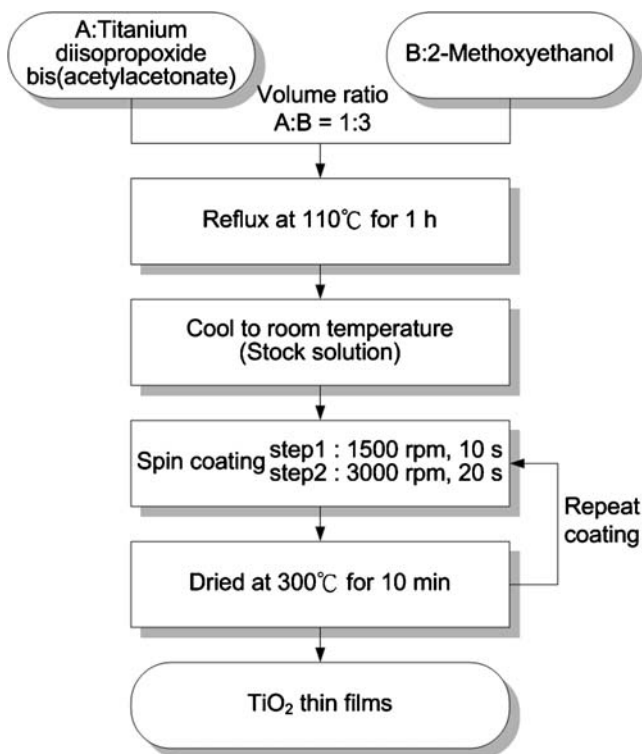


Fig. 1 Flow diagram of synthesis of electrochromic TiO_2 thin films

deposition (CSD). This technique has several advantages such as high homogeneity, precise compositional control and low cost, without the use of a high vacuum [11, 12]. This study discusses the effect of the amorphous and the anatase phases on the electrochromic properties of TiO_2 film. The dependence of the optical characteristics of an electrochromic TiO_2 film on its thickness is also considered.

Experimental

Preparation of TiO_2 thin films by CSD

Figure 1 shows a flow diagram of the preparation of electrochromic TiO_2 films by the CSD method. Titanium diisopropoxide

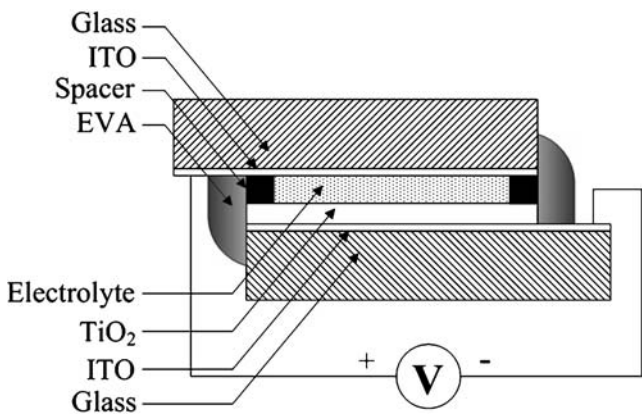


Fig. 2 Schematic configuration of electrochromic device (ECDs)

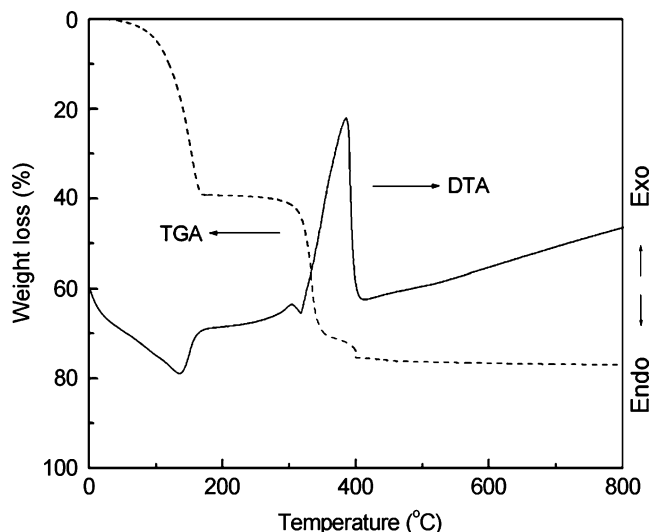


Fig. 3 Thermogravimetric analysis data (TGA) and corresponding DTA data for TiO_2 gel

oxide bis(acetylacetonate), $((\text{CH}_3)_2\text{CHO})_2\text{Ti}(\text{C}_5\text{H}_7\text{O}_2)_2$, was used as the source material and 2-methoxyethanol, $\text{CH}_3\text{OCH}_2\text{CH}_2\text{OH}$, was used as the solvent. The volume ratio of the TiO_2 source to the solvent was 1:3 to ensure adhesion of the stock solution to the substrate. The mixed solution was refluxed at 110°C for 1 h in air and then cooled to room temperature. The stock solution was thus obtained. The stock solution was spin-coated on ITO/glass substrates using a commercial photoresist spinner. The transparent and conductive ITO coated glass substrates with dimensions of $3 \times 3.5 \text{ cm}^2$, sheet resistance of $15 \Omega/\text{sq}$. and transmittance of 85%. The spin rate of the first step was 1,500 rpm for 10 s and the following step was 3,000 rpm for 20 s. TiO_2 wet films were heated at various temperatures ($200\text{--}500^\circ\text{C}$) in various concentrations of oxygen (0–80%) for 10 min in a rapid thermal process (RTP, heating rate= $1^\circ\text{C}/\text{s}$). In

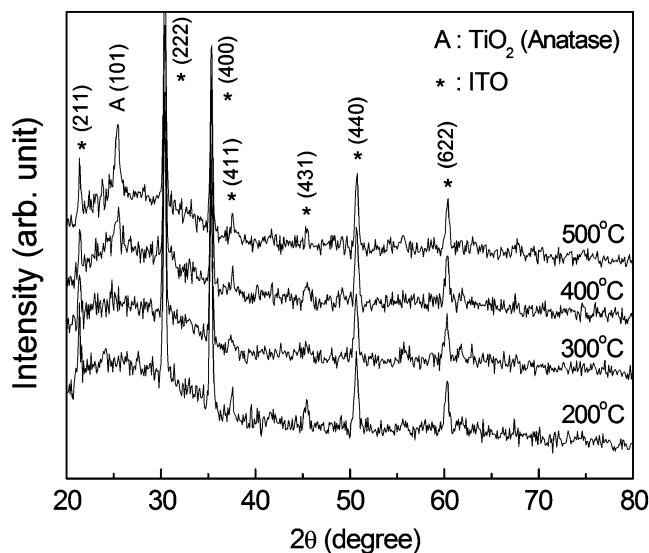
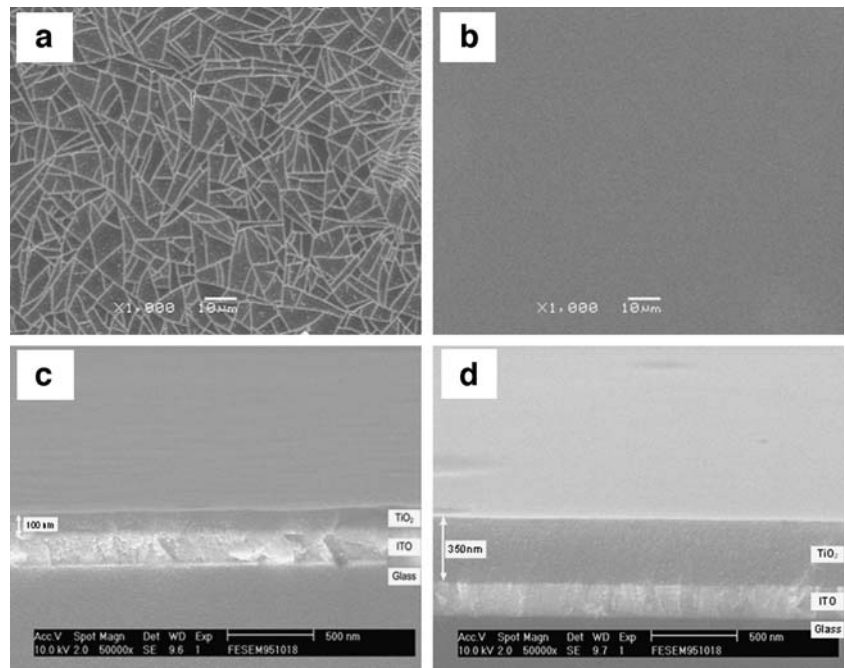


Fig. 4 XRD patterns of TiO_2 thin films heated at various temperatures

Fig. 5 SEM images of TiO₂ thin films heated at 300 °C for 10 min using **a** hot plate and **b** RTP, and cross-sectional views of the **c** 100 nm and **d** 350 nm TiO₂ films



addition, the RTP by an infrared gold image furnace will be adopted for the heating treatments of TiO₂ thin films. The RTP technology has been widely used in the semiconductor industry. This method has several advantages such as short heating time, rapid grain growth and avoids strains or reactions at the film–substrate interface and results in a dense microstructure [13, 14]. Various heat treatments were also performed at 300 °C for 10 min using a hot plate and RTP, respectively. The thicknesses of the TiO₂ films were very sensitive to the conditions of deposition including the concentration of the stock solution, the spin rate and the number of cycles in spin-coating/heating processes. In this study, the coating/heating operations were repeated until the desired thickness (100 or 350 nm) was obtained.

Fabrication and measurement of ECD devices

The thermal decomposition of the stock solution at various temperatures was examined by thermogravimetric analysis (TGA) and differential thermal analysis (DTA) at a heating

rate of 10°C/min. Crystal structures of TiO₂ films were analyzed by X-ray diffraction (XRD, Siemens D-5000) with Cu-K α radiation. The thickness and surface microstructures of the TiO₂ films were examined using a scanning electron microscope (SEM, JEOL JSM-6300). The electrochemical behaviors (cyclic voltammograms, CVs) of the films were examined using an electrochemical analyzer (CHI-611B) by immersing the sample in an electrolyte of 1 M LiClO₄ in PC. The CV measurements from +2.0 V to –3.8 V were made using potential sweeps of 50 mV/s. Ultraviolet–Visible (UV–Vis) spectra were obtained to measure the transmittance of each deposited specimen which was colored at –3.8 V and bleached at +2.0 V using a Jasco, V-570 spectrometer over the wavelength range 300–700 nm. The transmittance variation ($\Delta T\%$) is given by $\Delta T\% = T_{\text{Bleached}} - T_{\text{Colored}}$, where T_{Bleached} and T_{Colored} represent the transmittance at a wavelength (λ) of 550 nm in the bleaching and the coloring states, respectively. The change in the optical density (ΔOD) is given by $\Delta OD = \log(T_{\text{Bleached}}/T_{\text{Colored}})$ at a λ of 550 nm.

Table 1 The process parameters and measurement results of TiO₂ thin films

The process parameters and measurement results of TiO ₂ thin films								
Thickness (nm)	100	350	350	350	350	350	350	350
O ₂ (%)	0	0	40	60	80	60	60	60
Temperature (°C)	300	300	300	300	300	200	400	500
$T_{\text{As-prepared}}$ (%)	80.36	79.82	81.73	81.78	80.77	78.25	81.19	77.62
T_{Bleached} (%)	79.97	76.65	79.62	77.98	76.65	76.46	78.21	77.12
T_{Colored} (%)	78.62	67.06	65.83	63.78	66.36	75.57	67.19	73.2
ΔT (%)	1.35	9.59	13.79	14.2	10.29	0.89	11.02	3.92
ΔOD	0.007	0.058	0.082	0.087	0.062	0.005	0.065	0.022

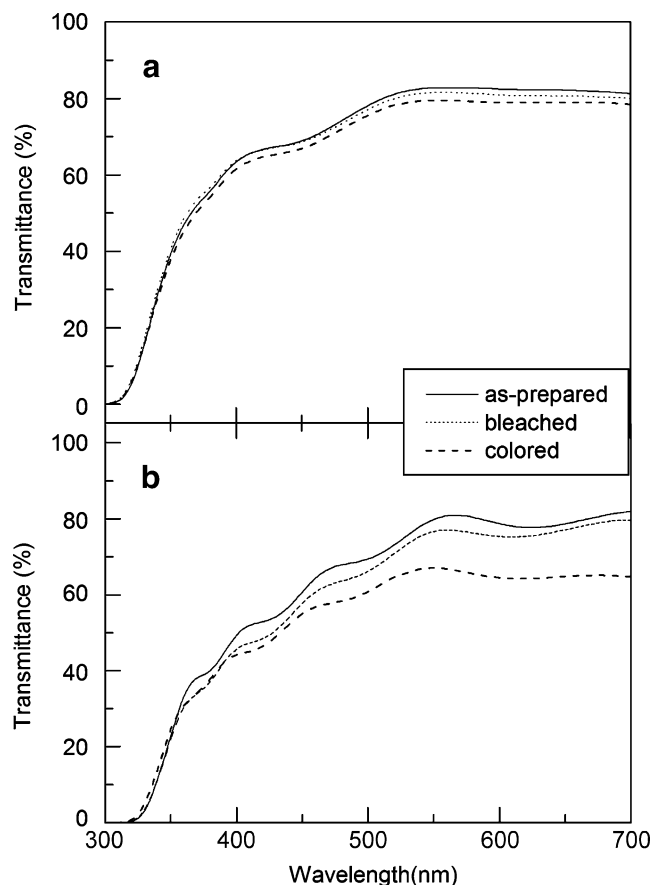


Fig. 6 Transmittance spectra of **a** 100 nm and **b** 350 nm TiO_2 thin films

Figure 2 shows a cross-sectional view of ECDs including the electrochromic TiO_2 layer. The device was assembled by separating the ITO/glass and the TiO_2 /ITO/glass by approximately 1 mm using a spacer. The free volume between the two electrodes was filled with the electrolyte. The entire device with the glass/ITO/electrolyte/ TiO_2 /ITO/glass structure was then sealed using ethylene vinyl acetate (EVA). This method is convenient optically characterizing an electrochromic TiO_2 film.

Results and discussion

Figure 3 plots the thermolysis behavior of TiO_2 gel. TGA analysis indicates that two major weight losses occurred at about 400 °C. The gel exhibited an approximately 80%-weight-loss over in the temperature range 100–400 °C by the elimination of adsorbed water and solvent (2-methoxyethanol whose b.p. is 122 °C) and the oxidation of the organic substances. The endothermic peaks at about 135 °C and 320 °C are associated with earlier weight losses. The amorphous-to-anatase phase transformation in TiO_2 is responsible for the exothermic peak at about 386 °C. These results are consistent with the values in the literature [15,

16]. Figure 4 presents the XRD patterns of the TiO_2 films heated to temperatures from 200 to 500 °C for 10 min. The film heated to 300 °C remained amorphous. However, crystalline TiO_2 films were obtained upon raising the heating temperature to over 400 °C. The crystallization of the TiO_2 film is consistent with the TGA/DTA plots, suggesting that the amorphous-to-anatase phase transformation temperature occurs at about 386 °C. Figure 4 also reveals an increase in the crystallinity with heating temperature.

Figure 5 presents SEM micrographs of TiO_2 films heated to 300 °C for 10 min using various heat-treatment methods. No microstructural feature of the films heated using a hot plate [Fig. 5a] and RTP [Fig. 5b] could be resolved. However, many cracks appeared on the surface, as shown in Fig. 5a, suggesting that heat treatment of the hot plate causes larger stresses and results in cracking [17]. Figure 5c and d present the uniform TiO_2 films that are obtained by RTP with a mean thickness of 100 nm and 350 nm, respectively. The thicknesses of the TiO_2 films did not increase significantly as the number of coating/heating cycles increased. Tu et al. [18] found that the ethanol route yielded a single-layer film that was thinner than those obtained by other routes. The coating/heating process was required to yield high-quality thin films of the desired thickness. Table 1 presents the experimental parameters and results.

Figure 6 presents the optical transmittance spectra of the 100 and 350-nm-thick TiO_2 films heated at 300 °C for 10 min by RTP. Inserting Li^+ ions changes the transmittance of TiO_2 films in the wavelength range of 300–700 nm and the color of the film changes reversibly from transparent to blue [19]. The transmittance (at 550 nm) of the 350-nm-thick TiO_2 film is varied from approximately 76.65% (bleached state) to 67.06% (colored state), and the corresponding $\Delta T\%$ and ΔOD are 9.59% and 0.058, respectively. Figure 7 plots the CVs of the 100-nm-thick

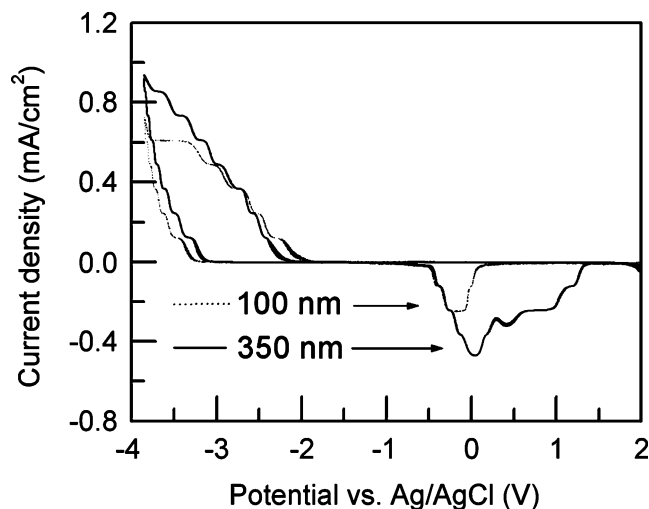
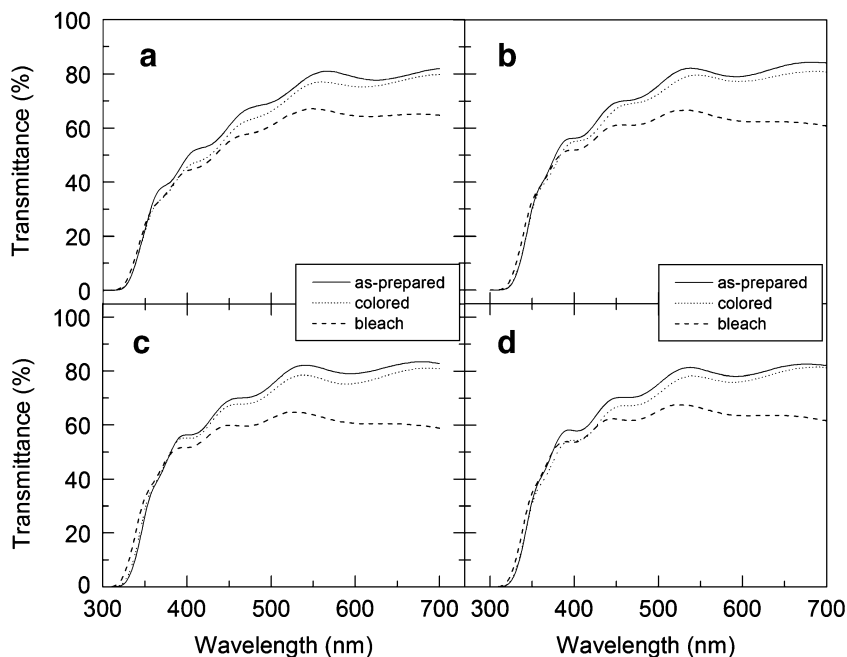


Fig. 7 Cyclic voltammograms of **a** 100 nm and **b** 350 nm TiO_2 thin films

Fig. 8 Transmittance spectra of TiO₂ thin films heated at 300 °C for 10 min in **a** 0%, **b** 40%, **c** 60% and **d** 80% oxygen

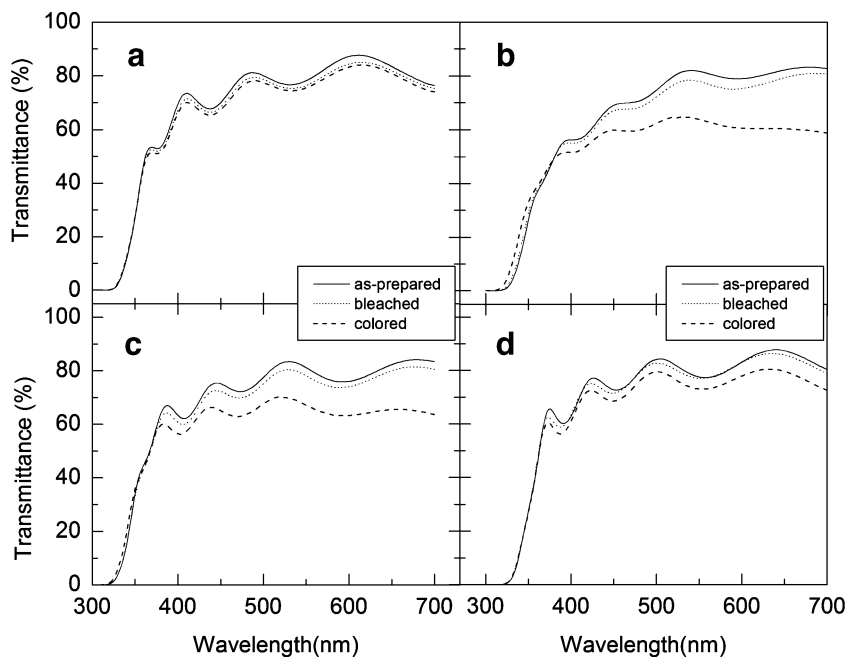


and 350-nm-thick TiO₂ films. The 100-nm TiO₂ film exhibits a reduction peak at -3.8 V (0.72 mA/cm²) and an oxidation peak at -0.18 V (-0.24 mA/cm²). The 350-nm TiO₂ film has a reduction peak at -3.8 V (0.94 mA/cm²) and an oxidation peak at 0.04 V (-0.46 mA/cm²). This result indicates that the thicker film has a larger charge capacity (amount of Li⁺ ion intercalation) [10, 20].

Figure 8 presents the transmittance spectra of the TiO₂ films relative to the oxygen content (0–80%) during heat treatment. A comparison across oxygen contents indicates that the TiO₂ film that was heated in 60% oxygen [Fig. 8c]

had the maximum $\Delta T\%$, 14.2% with a ΔOD of 0.087. The oxygen content affects the electrochromic properties of the TiO₂ film, which result is associated with the presence of oxygen vacancies and color centers [21–23]. Figure 9 plots the dependence of the transmittance spectra of TiO₂ films on the heating temperature (RTP, 200–500°C). $\Delta T\%$ and ΔOD decreased as the heating temperature increased over 300°C, because many fewer charges are injected into the crystalline TiO₂ film than into the amorphous film [24–27]. That is, Li⁺ ion intercalation in the amorphous TiO₂ film is much easier than in the anatase film because the former has

Fig. 9 Transmittance spectra of TiO₂ thin films heated at **a** 200 °C, **b** 300 °C, **c** 400 °C and **d** 500 °C in 60% oxygen content for 10 min



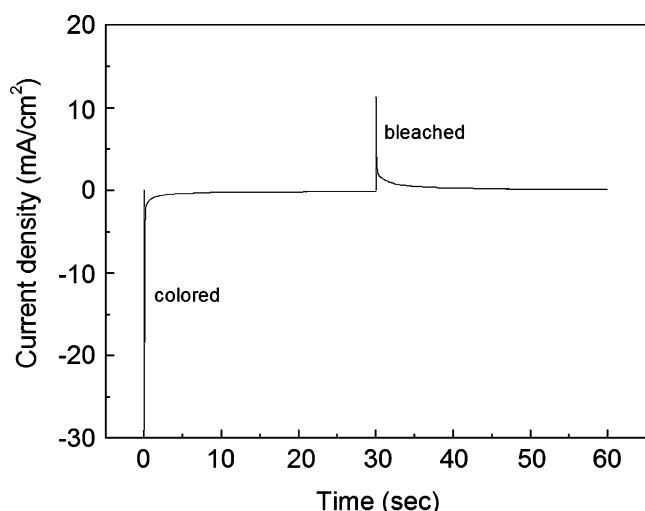


Fig. 10 Current response of 350-nm-thick TiO₂ film heated at 300 °C

a much more open microstructure. Figure 10 presents the Li⁺ ion intercalation/deintercalation charge (Q) in the colored and bleached stable states. First, the degree of coloration is monitored from 0 to 30 s for intercalation and from 30 to 60 s for deintercalation. The amount of charge from 0 to 30 s associated with intercalation during coloration is 10.9 mC/cm² and that from 30 to 60 s associated with deintercalated during bleaching is 9.7 mC/cm². The transmittance of the TiO₂ film in the colored state depends on the intercalated Li⁺ charge, specified by the insertion coefficient x for the Li _{x} TiO₂ compound. Accordingly, the maximum value of x is 0.076 in the colored state and 0.067 in the bleached state. Formulae for the intercalation/deintercalation coefficient x has been detailed elsewhere [10]. The coloration efficiency (η) is defined as $\eta = (\Delta OD/Q)$. When the 350-nm-thick TiO₂ film was heated at 300 °C in 60% oxygen, the η value was 7.98 cm²/C. Accordingly, the experimental η of 7.98 cm²/C exceeds that of a single-layer TiO₂ thin film deposited by rf magnetron sputtering [20].

Conclusions

TiO₂ electrochromic films were deposited on ITO/glass substrates by CSD. Additionally, ECDs were prepared for measurement of their optical and electrochromic properties. The phase transformation from the amorphous to the anatase TiO₂ film occurs at about 386 °C and the crystallinity increases with the heating temperature. The assembly of ECDs is convenient for electrochemical and optical characterization. As Li⁺ ions are inserted, the amorphous and anatase TiO₂ films become blue and light blue, respectively. In this study, the 350-nm-thick amorphous TiO₂ film obtained by RTP at an oxygen concentration of 60% and a

heating temperature of 300 °C has favorable electrochromic properties. The following electrochemical properties of TiO₂ films were obtained; (a) $\Delta T\%$ was 14.2% (λ at 550 nm), (b) ΔOD was 0.087 (λ at 550 nm), (c) Q was 10.9 mC/cm², (d) η was 7.98 cm²/C, (e) x in Li _{x} ClO₄ was 0.076. The amorphous TiO₂ films are suggested to be appropriate for ECD by CSD. Furthermore, such a film can be regarded as a buffer layer which increases the adhesion between the TiO₂ films (deposited by rf magnetron sputtering) and the ITO/glass substrate, improving the optical and electrochromic properties of ECDs [28].

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